

N-Channel Enhancement Mode MOSFET

Feature Pin Description

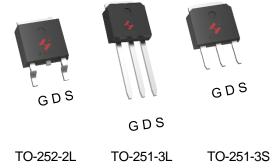
• 100V/50A

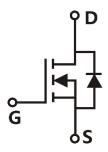
RDS(ON)= 11.9 m Ω (typ.) @VGS = 10V RDS(ON)= 15.9 m Ω (typ.) @VGS = 4.5V

- 100% Avalanche Tested
- 100% DVDS
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

Applications

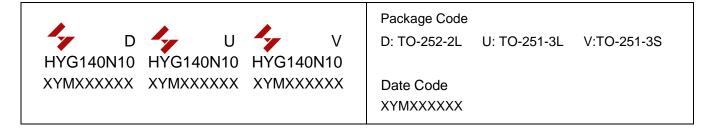
- AC-DC Switching Power Supply
- DC-DC Convertor





Single N-Channel MOSFET

Ordering and Marking Information



Note: HUAYI halogen free products contain molding compounds/die attach materials and 100% matte tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI halogen free products meet or exceed the halogen free require-ments of IPC/JEDEC J-STD-020 for MSL classification at halogen free peak reflow temperature. HUAYI defines "Green" to mean halogen free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Ratings (Tc=25°C Unless Otherwise Noted)				
VDSS	Drain-Source Voltage		100	V
Vgss	Gate-Source Voltage		±20	V
TJ	Junction Temperature Range		55 1. 475	°C
Tstg	Storage Temperature Range		-55 to 175	°C
Is	Source Current-Continuous(Body Diode)	Tc=25°C	50	А
Mounted on I	Large Heat Sink			
Ідм	Pulsed Drain Current *	Tc=25°C	180	А
	Cantinua de Brain Coment	Tc=25°C	50	А
lσ	Continuous Drain Current	Tc=100°C	36	А
1	N	Tc=25°C	78	W
Po	Maximum Power Dissipation	Tc=100°C	39	W
R₀uc	Thermal Resistance, Junction-to-Case		1.9	°C/W
R _{eJA}	Thermal Resistance, Junction-to-Ambient **		75	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.3mH	56.7	mJ

Note:

- * Repetitive rating; pulse width limited by max.junction temperature.
- ** Surface mounted on 1in2 FR-4 board.
- *** Limited by TJmax , starting TJ=25°C, L = 0.3mH, Rg= 25Ω , Vgs =10V.

Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Cumhal	Donomoto:	Test Conditions	HYG140N10		DLS1	1114:4
Symbol	Parameter	lest Conditions	Min	Тур.	Max	Unit
Static Cha	Static Characteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250µA	100	-	-	V
lnoo	Drain to Source Lookage Current	VDS=100V,VGS=0V	-	-	1	μΑ
IDSS	Ibss Drain-to-Source Leakage Current	TJ=125°C	-	-	50	μΑ
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	1	1.7	2.2	V
lgss	Gate-Source Leakage Current	$V_{GS}=\pm20V,V_{DS}=0V$	-	-	±100	nA
Dragovii)	Drain Source On State Registeres	V _{GS} =10V,I _{DS} =20A		11.9	14.5	mΩ
Rds(on)	Drain-Source On-State Resistance V _{GS} =4.5V,I _{DS} =20A			15.9	20	mΩ
Diode Cha	Diode Characteristics					
VsD	Diode Forward Voltage	IsD=20A,Vgs=0V	-	0.88	1.3	V
trr	Reverse Recovery Time	lan 200 dlan/dt 1000/ug	-	33.8	-	ns
Qrr	Reverse Recovery Charge	- Isp=20A,dIsp/dt=100A/µs	-	30.5	-	nC

HYG140N10LS1D/U/V



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cumbal	Barranatan	Took Conditions	Test Conditions HYG140N1	G140N10	LS1	l losis
Symbol	ymbol Parameter Test 0		Min	Тур.	Max	Unit
Dynamic	Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	1.4	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	1236	-	
Coss	Output Capacitance	V _{DS} = 25V,	-	471	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1MHz	-	33.2	-	
td(ON)	Turn-on Delay Time		-	10	-	
Tr	Turn-on Rise Time	$V_{DD}=50V,R_{G}=5\Omega,$	-	29.6	-]
td(OFF)	Turn-off Delay Time	lps=20A,Vgs=10V	-	34.6	-	ns
Tf	Turn-off Fall Time		-	69.7	-	
Gate Cha	rge Characteristics					
	Total Gate Charge(V _{GS} =10V)		-	21	-	
Q_g	Total Gate Charge(V _{GS} =4.5V)			10.6		·- C
Qgs	Gate-Source Charge	V _{DS} =80V, I _{DS} =20A	-	5	-	nC
Qgd	Gate-Drain Charge		-	3.8	-	
V _{plateau}	Gate plateau voltage		-	3.5	-	V

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



Typical Operating Characteristics

Figure 1: Power Dissipation

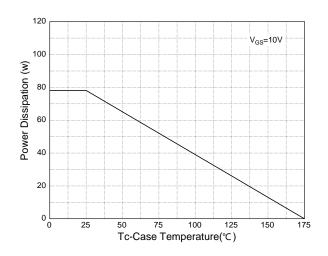


Figure 3: Safe Operation Area

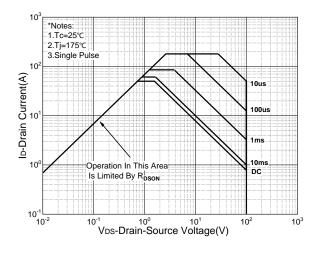


Figure 5: Output Characteristics

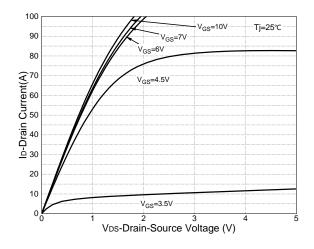


Figure 2: Drain Current

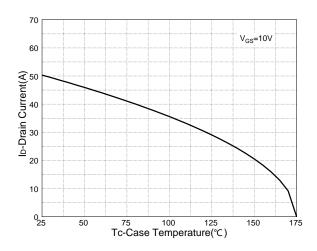


Figure 4: Thermal Transient Impedance

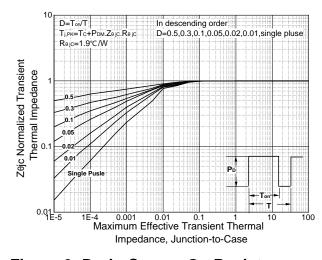
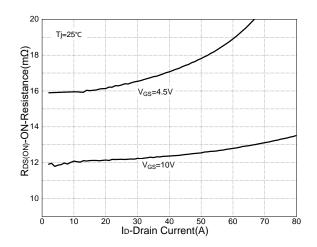


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

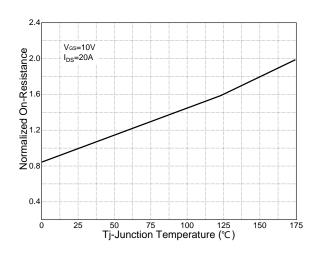


Figure 8: Source-Drain Diode Forward

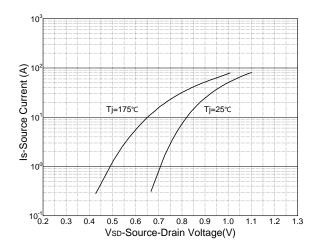


Figure 9: Capacitance Characteristics

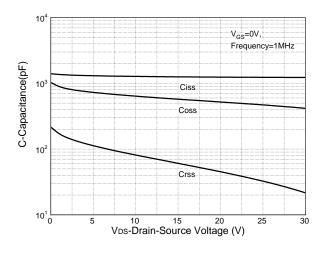
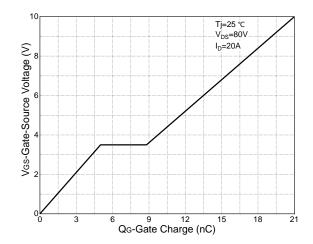
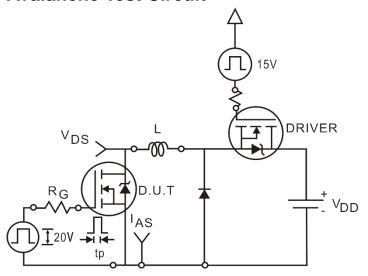


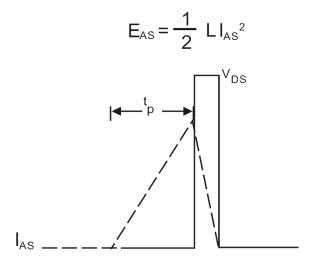
Figure 10: Gate Charge Characteristics



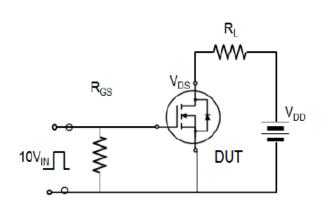


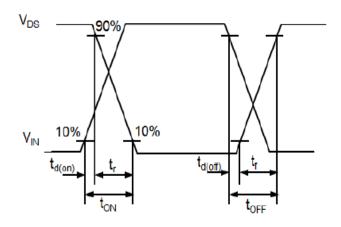
Avalanche Test Circuit



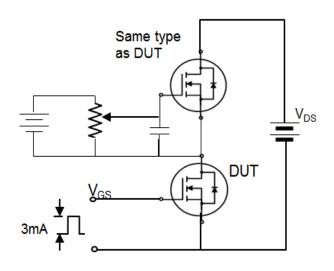


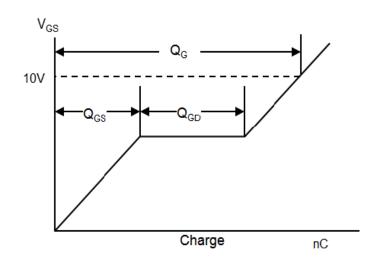
Switching Time Test Circuit





Gate Charge Test Circuit





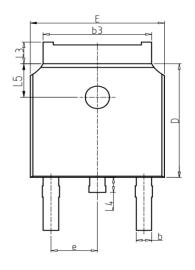


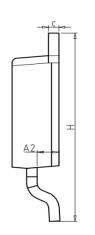
Device Per Unit

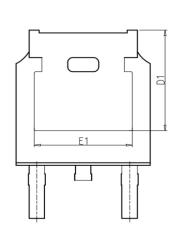
Package Type	Unit	Quantity
TO-252-2L	Tube	75
TO-252-2L	Reel	2500
TO-251-3L	Tube	75
TO-251-3S	Tube	75

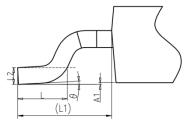
Package Information

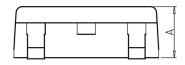
TO-252-2L







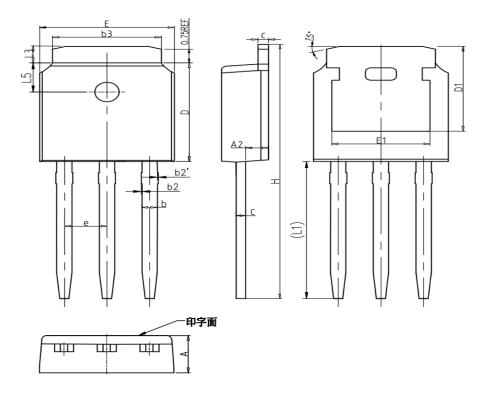




COMMON DIMENSIONS			
SYMBOL		mm	
STIVIDOL	MIN	NOM	MAX
А	2.20	2.30	2.40
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.50
С	0.43	0.53	0.63
D	5.98	6.10	6.22
D1	5.30REF		
Е	6.40	6.60	6.80
E1	4.63	-	-
е		2.286BS0	
Н	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90REF		
L2	0.51BSC		
L3	0.88	-	1.28
L4	-	-	1.00
L5	1.65	1.80	1.95
θ	0°	-	8°



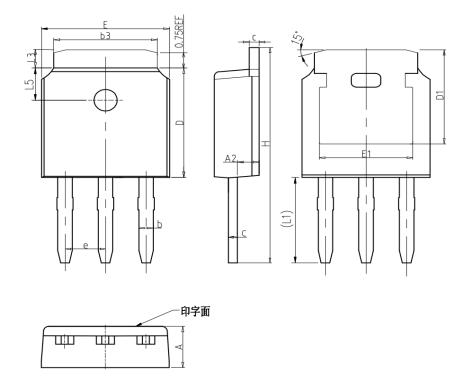
TO-251-3L



COMMON DIMENSIONS			
SYMBOL	mm		
STIVIDOL	MIN	NOM	MAX
А	2.20	2.30	2.40
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b2	0.00	0.04	0.10
b2'	0.00	0.04	0.10
b3	5.20	5.33	5.50
С	0.43	0.53	0.63
D	5.98	6.10	6.22
D1		5.30REF	
E	6.40	6.60	6.80
E1	4.63	-	-
е	2.286BSC		
Н	16.22	16.52	16.82
L1	9.15	9.40	9.65
L3	0.88	1.02	1.28
L5	1.65	1.80	1.95



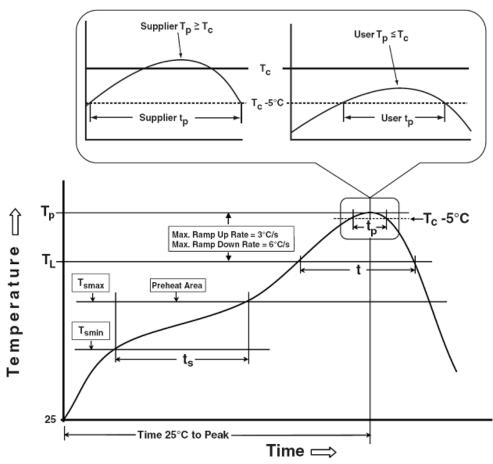
TO-251-3S



COMMON DIMENSIONS			
SYMBOL	mm		
STIVIBUL	MIN	NOM	MAX
А	2.20	2.30	2.40
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.50
С	0.43	0.53	0.63
D	5.98	6.10	6.22
D1		5.30REF	
E	6.40	6.60	6.80
E1	4.63	-	-
е	2.286BSC		
Н	10.00	11.22	11.44
L1	3.90	4.10	4.30
L3	0.88	1.02	1.28
L5	1.65	1.80	1.95



Classification Profile



Classification Reflow Profiles

Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak	
100 °C	150 °C
150 °C	200 °C
60-120 seconds	60-120 seconds
2 °C/cocond mov	2°C/22221d may
3 C/second max.	3°C/second max.
183 °C	217 °C
60-150 seconds	60-150 seconds
See Classification Temp in table 1	SacClassification Tomain table 2
See Classification Temp in table 1	SeeClassification Tempin table 2
20** accords	20** accords
20 seconds	30** seconds
6 °C/second max.	6 °C/second max.
6 minutes max.	8 minutes max.
	Preheat & Soak 100 °C 150 °C 60-120 seconds 3 °C/second max. 183 °C 60-150 seconds See Classification Temp in table 1 20** seconds 6 °C/second max.

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 /500 Hrs, Vgs100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
тст	JESD-22, A104	250/500 Cycles, -55°C~150°C

Customer Service

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